

Application No.	Applicant(s)	·······
09/937,167	KREUZER ET AL.	
Examiner	Art Unit	
Paul D Kim	3729	

	SEARCHED				
Class	Subclass	Date	Examiner		
29	592.1 596 598 605 606 609 736 751 753	12/14/2004	РК		
140	92.1	12/14/2004	РК		
100	214	12/14/2004	PK		
310	90 179 184	12/14/2004	РК		
	198 208				
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IN	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAR		)
	DATE	EXMR
Consulted by Lowell Larson (72)	12/14/2004	РК
Text Search EAST/NPL (IEEE)	12/14/2004	РК
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